Notice of References Cited Application/Control No. 10/092,300 Examiner Reexamination KWEON ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
	Α	US-6,797,435	09-2004	Kweon et al.	429/231.95
	В	US-2003/0054250	03-2003	Kweon et al.	429/231.1
	С	US-2003/0003352	01-2003	Kweon et al.	429/137
	D	US-2002/0071990	06-2002	Kweon et al.	429/231.1
	Е	US-2004/0018429	01-2004	Kweon et al.	429/232
	F	US-6,753,111	06-2004	Kweon et al.	429/231.95
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
_	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09-171813	06-1997	Japan	Benno et al	H01M 04/02
	0					
	Р					
	Q					
	R				*	
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.